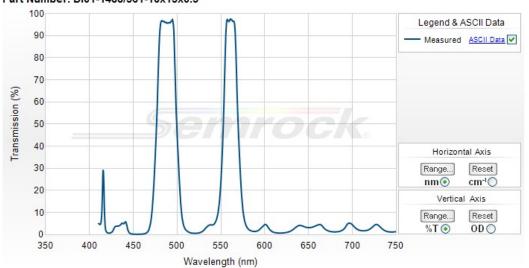
# 488/561 nm Yokogawa dichroic beamsplitter

## Part Number: Di01-T488/561-13x15x0.5





### Semrock, Inc.

3625 Buffalo Road, Suite 6 Rochester, New York 14624

Main Phone: +1 585.594.7050 (worldwide)
Toll Free Phone: 866.736.7625 (866-SEMROCK)
(within US and Canada)

Your filter spectrum may differ slightly from the typical spectrum above, but is certified to meet the optical specifications noted below.



#### 488/561 nm Yokogawa dichroic beamsplitter

Combining superior performance with exceptional durability, these filters are specifically optimized for use with all Yokogawa CSU spinning-disk scan head system configurations.

Part Number	Size	Price1	Stock Status
Di01-T488/561-13x15x0.5	13 mm x 15 mm x 0.5 mm (unmounted)	\$625	In Stock

This part is not available for custom sizing.

1) US domestic pricing only. If you are ordering from outside the US, please contact your nearest regional distributor for the correct list price.

### **Optical Specifications**

Specification	Value
Reflection Band 1	Ravg > 95% 422 – 467 nm
Edge Wavelength 1	476 nm
Transmission Band 1	Tavg > 85% 483 - 493 nm
Reflection Band 2	Ravg > 95% 509 – 542 nm
Edge Wavelength 2	553 nm
Transmission Band 2	Tavg > 85% 560 - 563 nm
Reflection Band 3	Ravg > 95% 577 – 750 nm

#### **General Filter Specifications**

Specification	Value	
Laser Wavelength 1	488 nm	
Laser Wavelength 2	561.4 nm	
Angle of Incidence	45 ± 1.5 degrees	
Cone Half-angle	0.5 degrees	
Optical Damage Rating	Not Tested	
Flatness	<u>Laser Flat</u>	
Steepness	Steep	
Effective Index	1.90	

#### Physical Filter Specifications (applies to standard sized parts; contact us regarding other sizes)

Specification	Value
Transverse Dimensions (L x W)	13.0 mm x 15.0 mm
Transverse Tolerance	+ 0.0 / - 0.2 mm
Filter Thickness (unmounted)	0.5 mm

e programma a la comitación de la comita	
Filter Thickness Tolerance (unmounted)	± 0.02 mm
Clear Aperture	≥ 80% (elliptical)
Scratch-Dig	40-20
Substrate Thickness (unmounted)	0.5 mm
Substrate Thickness Tolerance (unmounted)	± 0.02 mm
Orientation	Unmarked (reflective coating towards sample)